



High CMR, 1Mbit/s High Speed Optocoupler

www.ct-micro.com

Features

- High speed 1Mbit/s
- High isolation voltage between input and output (Viso=5000 Vrms)
- Guaranteed CTR performance from 0°C to 70°C
- Operating temperature range -55°C to 100°C
- RoHS and REACH Compliance
- MSL class 1
- Regulatory Approvals
 - ✓ UL - UL1577 (E364000)
 - ✓ VDE - EN60747-5-5(VDE0884-5)
 - ✓ CQC – GB4943.1, GB8898(14001104779)
 - ✓ IEC62368 (FI/41119)

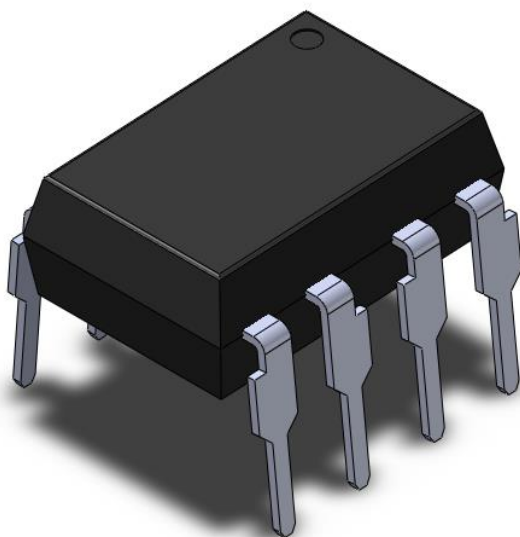
Description

The CT3120 consists of a LED optically coupled to an integrated circuit with a power output stage. This optocoupler is ideally suited for driving power IGBTs and MOSFETs used in motor control inverter applications. The high operating voltage range of the output stage provides the drive voltages required by gate-controlled devices.

Applications

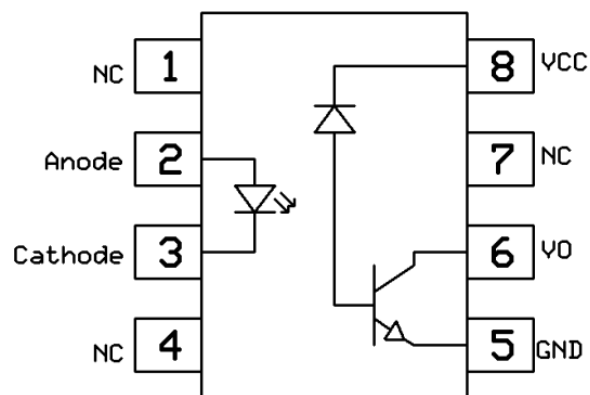
- Isolated IGBT/Power MOSFET gate drive
- Industrial Inverter
- AC brushless and DC motor drives
- Induction Heating

Package Outline



Note: Different lead forming options available. See package dimension.

Schematic





High CMR, 1Mbit/s High Speed Optocoupler

www.ct-micro.com**Absolute Maximum Ratings** $T_A = 25^{\circ}\text{C}$, unless otherwise specified

Stresses in excess of the absolute maximum ratings can cause permanent damage to the device. Functional operation of the device is not implied at these or any other conditions in excess of those given in the operational sections of this document. In addition, extended exposure to stresses above the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only.

Symbol	Parameters	Ratings	Units	Notes
V _{ISO}	Isolation voltage (AC, 1 minute, 40 ~ 60% R.H.)	5000	V _{RMS}	
T _{OPR}	Operating temperature	-55 ~ +100	°C	
T _{STG}	Storage temperature	-55 ~ +125	°C	
T _{SOL}	Soldering temperature (For 10 seconds)	260	°C	
Emitter				
I _F	Forward current	25	mA	
I _{FP}	Peak forward current (50% duty, 1ms P.W)	50	A	
I _{F(TRANS)}	Peak transient current ($\leq 1\mu\text{s}$ P.W, 300pps)	1	A	
V _R	Reverse voltage	5	V	
P _D	Power dissipation	45	mW	
Detector				
P _D	Power dissipation	250	mW	
V _{EBR}	Emitter-Base reverse voltage	5	V	
I _B	Base current	5	mA	
I _{C(AVG)}	Average Output current	8	mA	
I _{C(Peak)}	Peak Output current	16	mA	
V _{CC}	Supply voltage	0 to 30	V	

**Electrical Characteristics** $T_A = 0 - 70^\circ\text{C}$ (unless otherwise specified). Typical values are measured at $T_A = 250\text{C}$ and $V_{CC}=5\text{V}$ **Emitter Characteristics**

Symbol	Parameters	Test Conditions	Min	Typ	Max	Units	Notes
V_F	Forward voltage	$I_F = 16\text{mA}$	-	1.45	1.8	V	
V_R	Reverse Voltage	$I_R = 10\mu\text{A}$	5.0	-	-	V	
$\Delta V_F/\Delta T_A$	Temperature coefficient of forward voltage	$I_F = 16\text{mA}$	-	-1.8	-	mV/ $^\circ\text{C}$	

Detector Characteristics

Symbol	Parameters	Test Conditions	Min	Typ	Max	Units	Notes
I_{OH}	Logic High Output Current	$I_F=0\text{mA}$, $V_O=V_{CC}=5.5\text{V}$, $T_A=25^\circ\text{C}$	-	0.001	0.5	μA	
		$I_F=0\text{mA}$, $V_O=V_{CC}=15\text{V}$, $T_A=25^\circ\text{C}$	-	0.01	1		
		$I_F=0\text{mA}$, $V_O=V_{CC}=15\text{V}$	-	-	50		
I_{CCL}	Logic Low Supply Current	$V_F = 0$ to 0.8V , $V_O = \text{Open}$	-	140	200	μA	
I_{CCH}	Logic High Supply Current	$I_F=0\text{mA}$, $V_O=\text{Open}$, $V_{CC}=15\text{V}$, $T_A=25^\circ\text{C}$	-	0.01	1	μA	
		$I_F=0\text{mA}$, $V_O=\text{Open}$, $V_{CC}=15\text{V}$	-	-	2		

Transfer Characteristics

Symbol	Parameters	Test Conditions	Min	Typ	Max	Units	Notes
CTR	Current Transfer Ratio	$I_F=16\text{mA}$, $V_O=0.4\text{V}$, $V_{CC}=4.5\text{V}$, $T_A=25^\circ\text{C}$	25	35	60	%	
		$I_F=16\text{mA}$, $V_O=0.5\text{V}$, $V_{CC}=4.5\text{V}$	21	40	-		
		$I_F=12\text{mA}$, $V_O=0.4\text{V}$, $V_{CC}=4.5\text{V}$, $T_A=25^\circ\text{C}$	26	38	65		
		$I_F=12\text{mA}$, $V_O=0.5\text{V}$, $V_{CC}=4.5\text{V}$	22	43	-		
V_{OL}	Logic Low Output Voltage	$I_F=16\text{mA}$, $I_O=4.0\text{mA}$, $V_{CC}=4.5\text{V}$, $T_A=25^\circ\text{C}$	-	0.2	0.4	V	
		$I_F=16\text{mA}$, $I_O=3.3\text{mA}$, $V_{CC}=4.5\text{V}$	-	-	0.5		



High CMR, 1Mbit/s High Speed Optocoupler

Electrical Characteristics *TA = 0 - 70°C (unless otherwise specified). Typical values are measured at TA = 25°C and VCC=5V*

Switching Characteristics

Symbol	Parameters	Test Conditions	Min	Typ	Max	Units	Notes
T _{PHL}	Propagation Delay Time Logic High to Logic Low	I _F =16mA, V _{CC} =5.0V, R _L =1.9kΩ, C _L =15pF, V _{THHL} =1.5V, T _A =25°C	-	0.24	0.3	μs	
		I _F =16mA, V _{CC} =5.0V, R _L =1.9kΩ, C _L =15pF, V _{THHL} =1.5V	-	0.24	0.5		
		I _F =12mA, V _{CC} =15.0V, R _L =20kΩ, C _L =100pF, V _{THHL} =1.5V, T _A =25°C	-	0.58	0.7		
		I _F =12mA, V _{CC} =15.0V, R _L =20kΩ, C _L =100pF, V _{THHL} =1.5V	-	-	1.0		
T _{PLH}	Propagation Delay Time Logic Low to Logic High	I _F =16mA, V _{CC} =5.0V, R _L =1.9kΩ, C _L =15pF, V _{THLH} =1.5V, T _A =25°C	-	0.21	0.5	μs	
		I _F =16mA, V _{CC} =5.0V, R _L =1.9kΩ, C _L =15pF, V _{THLH} =1.5V	-	0.21	0.7		
		I _F =12mA, V _{CC} =15.0V, R _L =20kΩ, C _L =100pF, V _{THLH} =2.0V, T _A =25°C	-	0.76	1.1		
		I _F =12mA, V _{CC} =15.0V, R _L =20kΩ, C _L =100pF, V _{THLH} =2.0V	-	0.76	1.4		
T _{PLH} -T _{PHL}	Propagation Delay Difference	I _F =12mA, V _{CC} =15.0V, R _L =20kΩ, C _L =100pF, V _{THHL} =1.5V, V _{THLH} =2.0V, T _A =25°C	-0.4	0.3	0.9	μs	
		I _F =12mA, V _{CC} =15.0V, R _L =20kΩ, C _L =100pF	-0.7	0.3	1.3		
CM _H	Common Mode Transient Immunity at Logic High	I _F = 0mA, V _{CM} =1.5kVp-p, V _{CC} =5V, R _L =1.9kΩ, C _L =15pF, T _A =25°C	15000	30000	-	V/μs	
		I _F = 0mA, V _{CM} =1.5kVp-p, V _{CC} =15V, R _L =20kΩ, C _L =100pF, T _A =25°C	15000	30000	-		
CM _L	Common Mode Transient Immunity at Logic Low	I _F = 12mA, V _{CM} =1.5kVp-p, V _{CC} =5V, R _L =1.9kΩ, C _L =15pF, T _A =25°C	15000	30000	-	V/μs	
		I _F = 16mA, V _{CM} =1.5kVp-p, V _{CC} =15V, R _L =20kΩ, C _L =100pF, T _A =25°C	15000	30000	-		



Typical Characteristic Curves $T_A = 25^\circ\text{C}$, unless otherwise specified

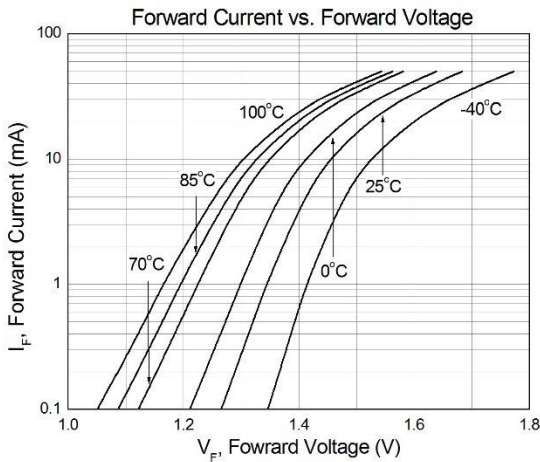


Figure 1

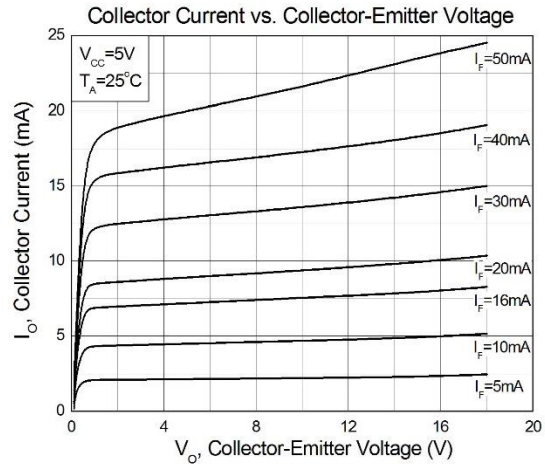


Figure 2

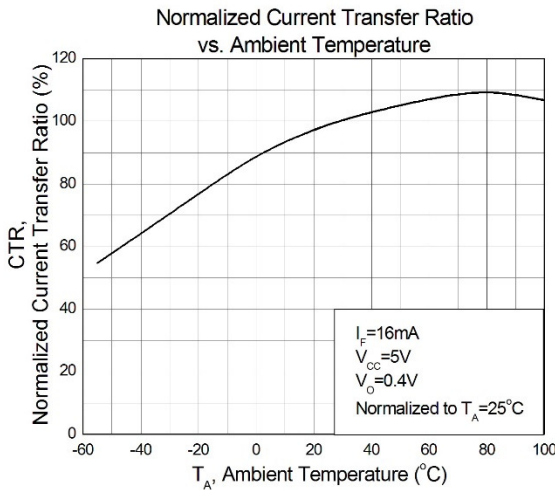


Figure 3

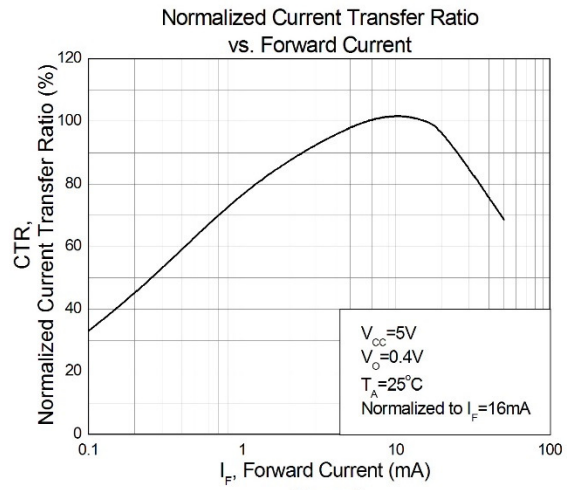


Figure 4

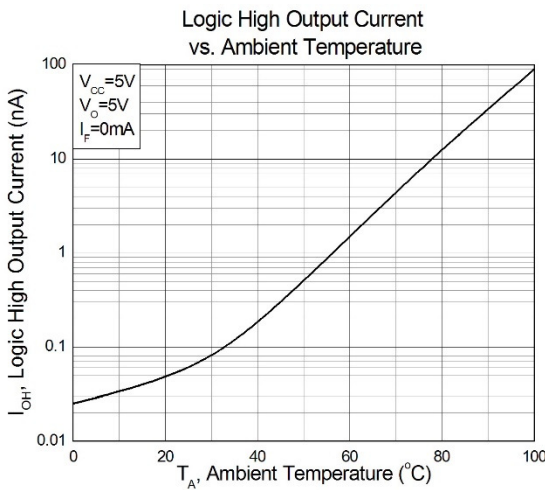


Figure 5

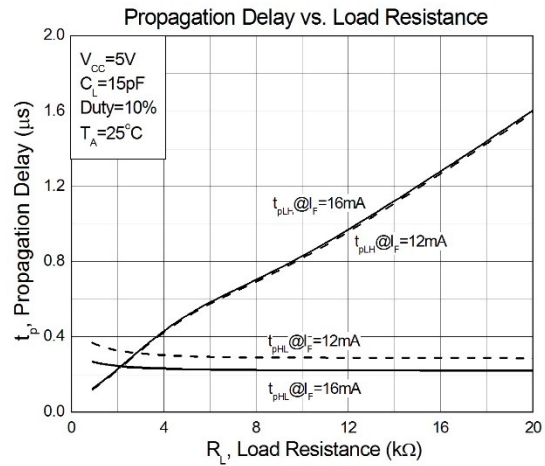
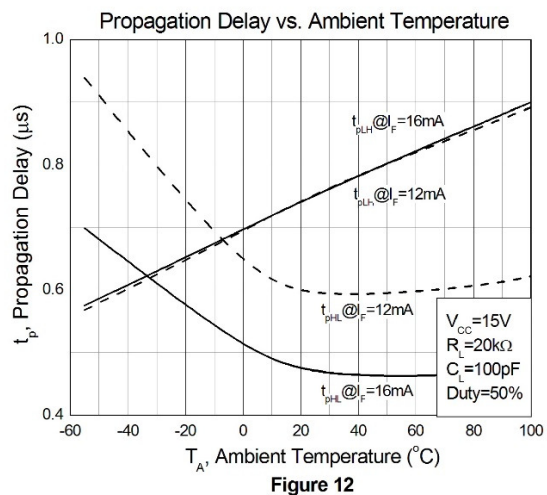
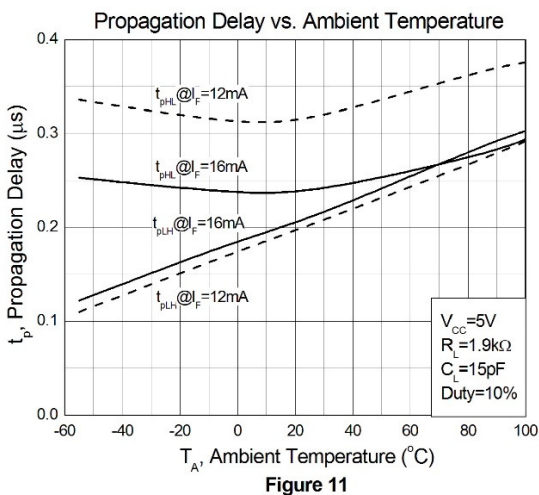
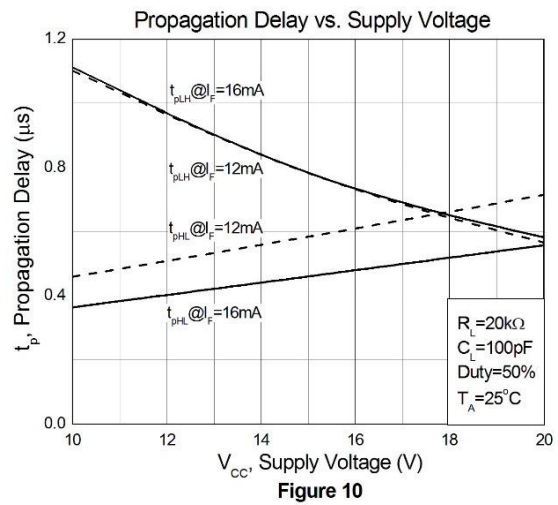
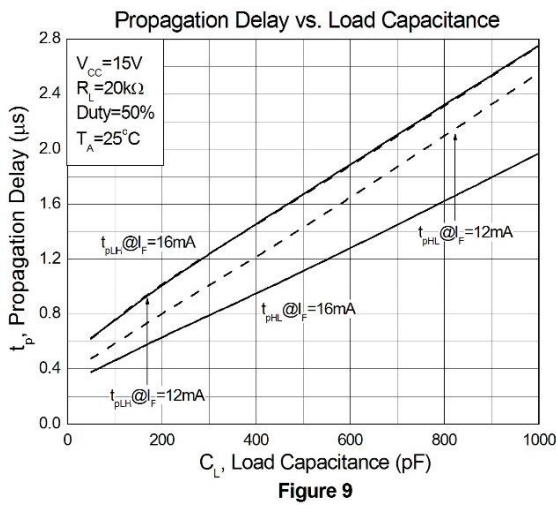
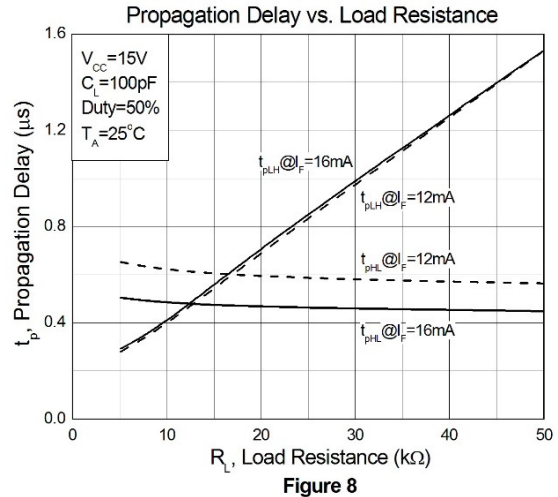
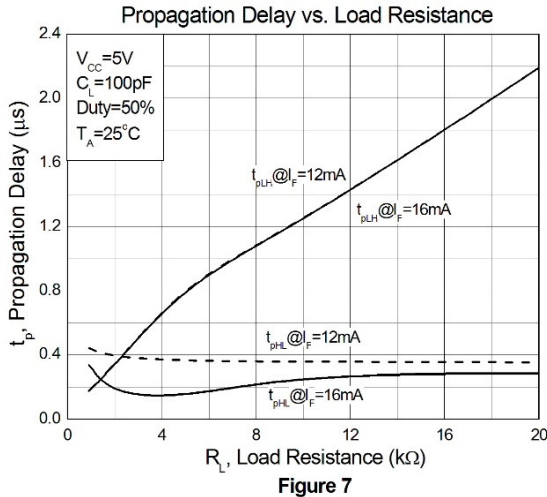


Figure 6



Typical Characteristic Curves $T_A = 25^\circ\text{C}$, unless otherwise specified





Test Circuits

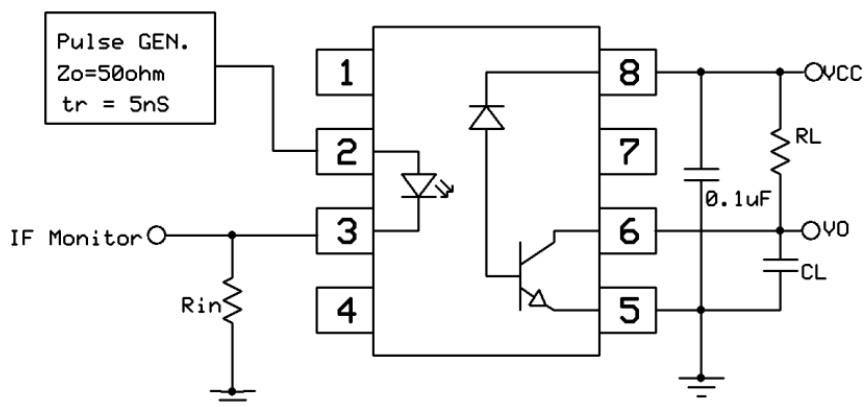


Figure 13: Switching Time Test Circuits



Test Circuits

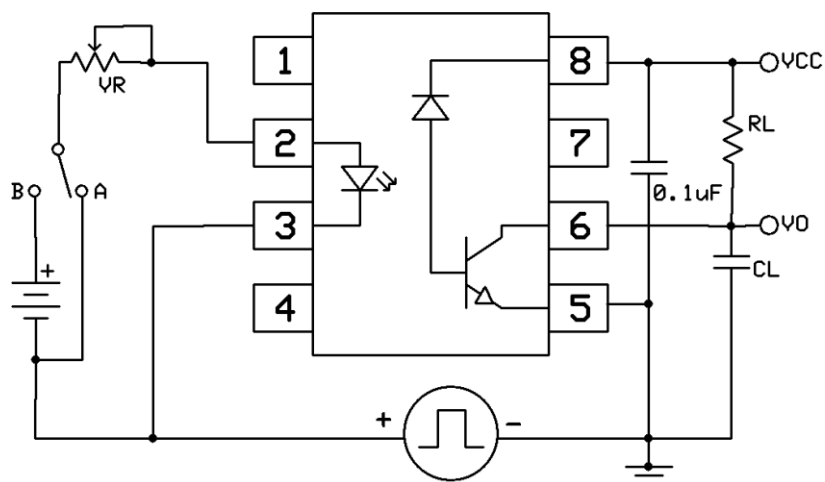
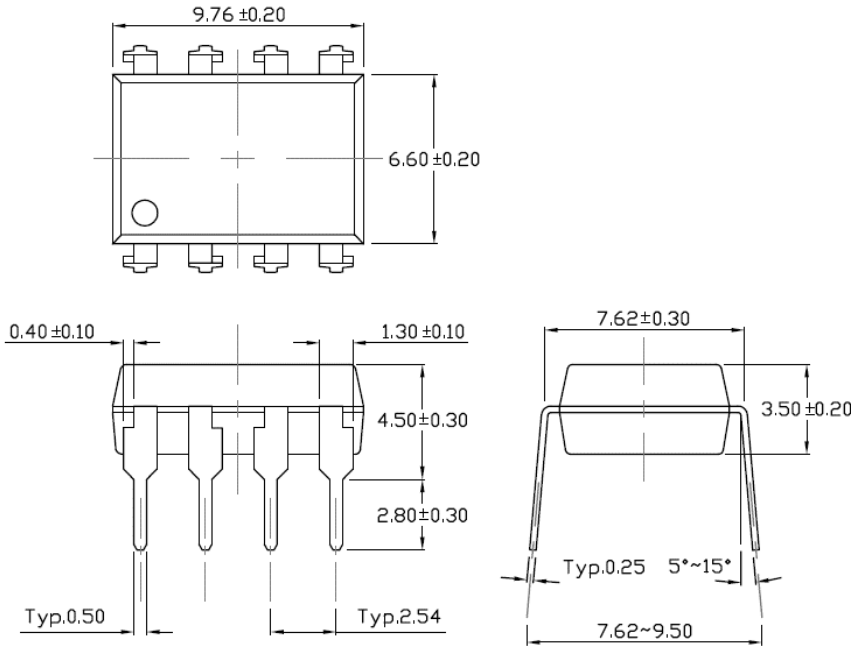


Figure 14: CMR Test Circuits



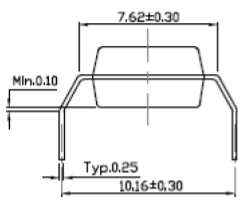
Package Dimension *Dimensions in mm unless otherwise stated*

Standard DIP – Through Hole

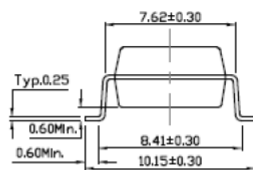


Forming Option *Dimensions in mm unless otherwise stated*

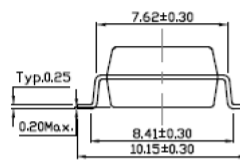
M Type



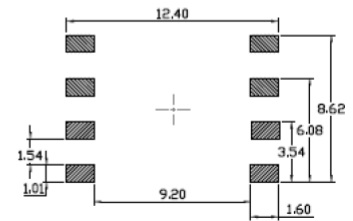
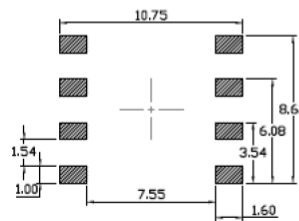
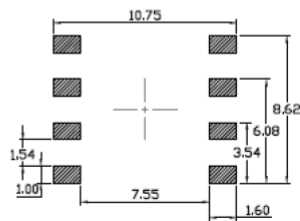
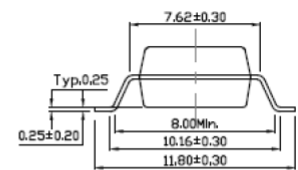
S Type



SL Type

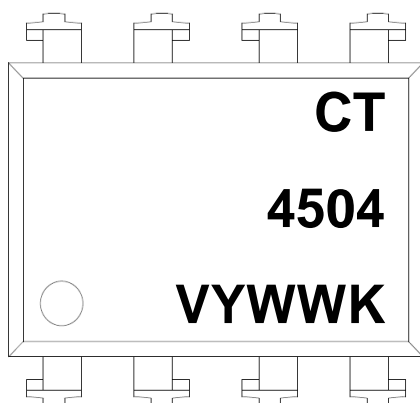


SLM Type





Marking Information



Note:

- CT : Denotes “CT Micro”
- 4504 : Part Number
- V : VDE Safety Mark Option (Blank or V)
- Y : One Digit Year Code
- WW : Two Digit Work Week
- K : Manufacturing Code

Ordering Information

CT4504(V)(Y)(Z)

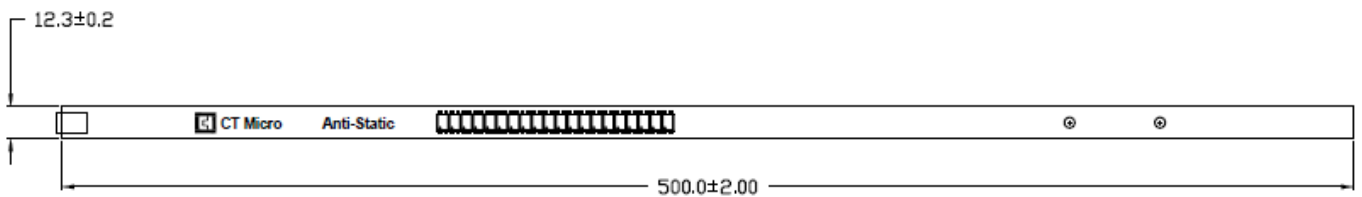
- CT = Denotes “CT Micro”
- 4504 = Part Number
- V = VDE Safety Mark Option (Blank or V)
- Y = Lead Form Option (S, SL, M, SLM or none)
- Z = Tape and Reel Option (Blank, T1 or T2)

Option	Description	Quantity
None	Standard 8 Pin Dip	40 Units/Tube
M	Gullwing (400mil) Lead Forming	40 Units/Tube
S(T1)	Surface Mount Lead Forming – With Option 1 Taping	1000 Units/Reel
S(T2)	Surface Mount Lead Forming – With Option 2 Taping	1000 Units/Reel
SL(T1)	Surface Mount (Low Profile) Lead Forming– With Option 1 Taping	1000 Units/Reel
SL(T2)	Surface Mount (Low Profile) Lead Forming – With Option 2 Taping	1000 Units/Reel
SLM(T1)	Surface Mount (Gullwing) Lead Forming– With Option 1 Taping	1000 Units/Reel
SLM(T2)	Surface Mount (Gullwing) Lead Forming – With Option 2 Taping	1000 Units/Reel

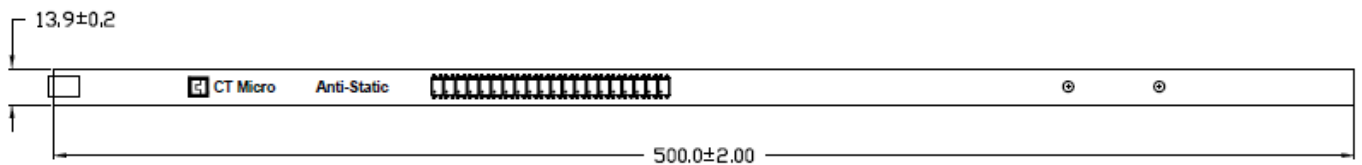


Carrier Specifications *Dimensions in mm unless otherwise stated*

Tube Option Standard DIP

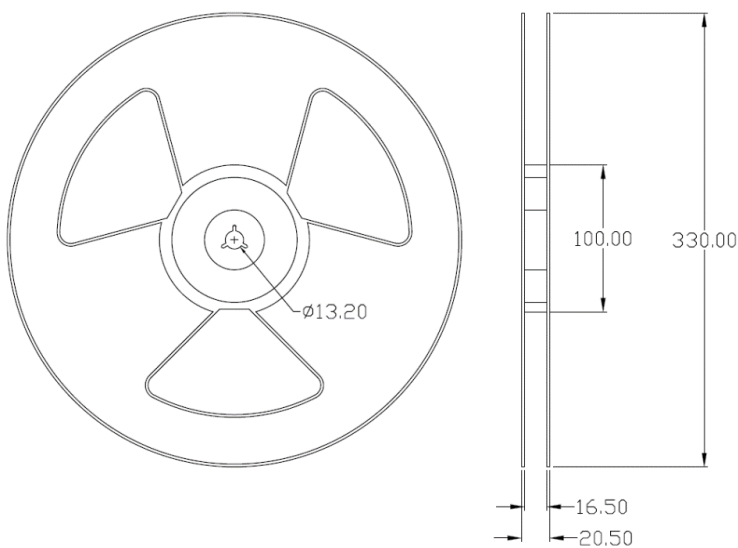


Tube Option M Type

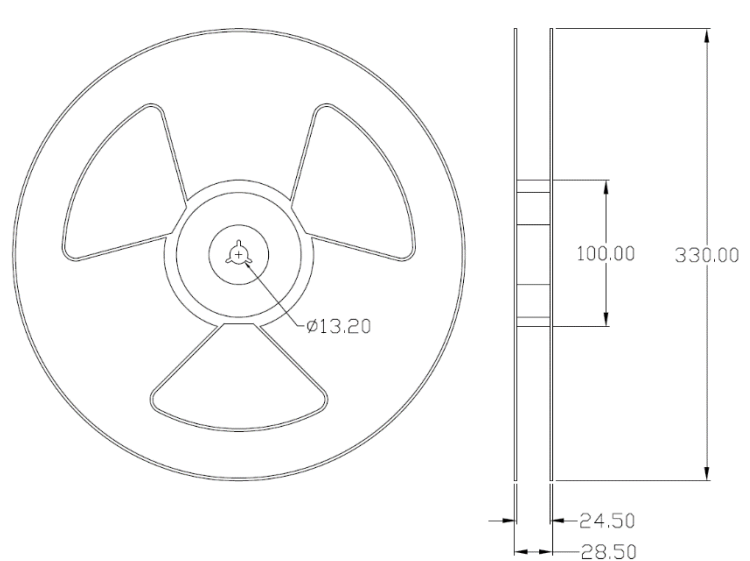


Reel Dimension *All dimensions are in mm, unless otherwise stated*

Option S(T1/T2) & SL(T1/T2)



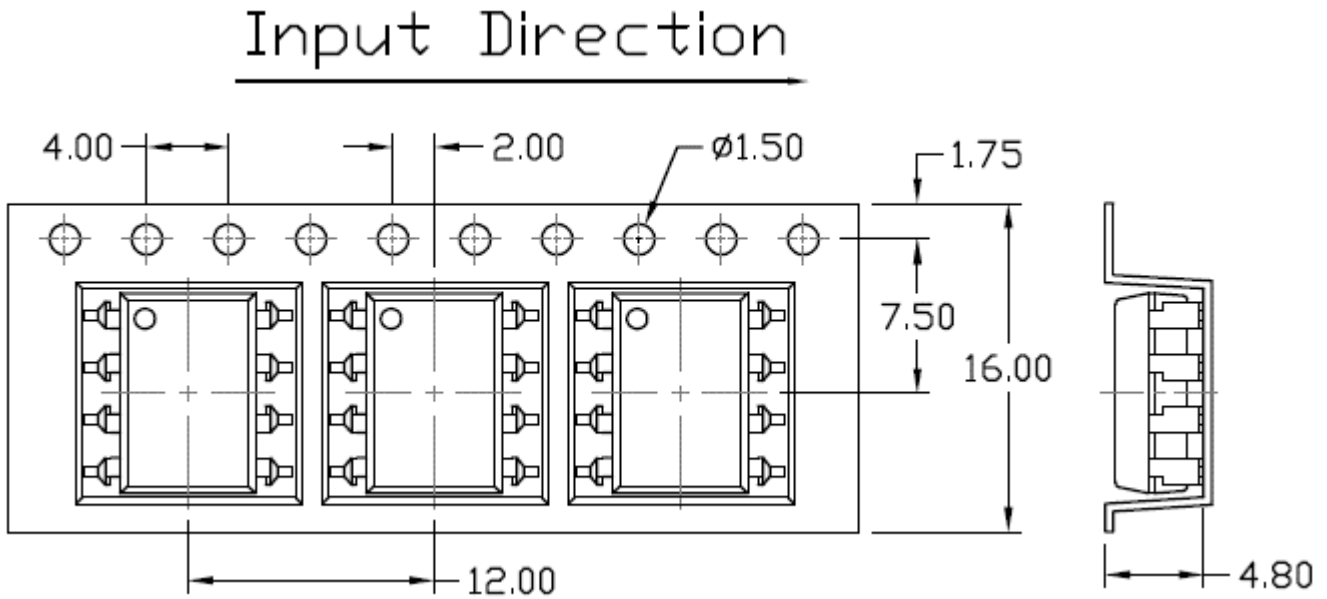
Option SLM(T1/T2)



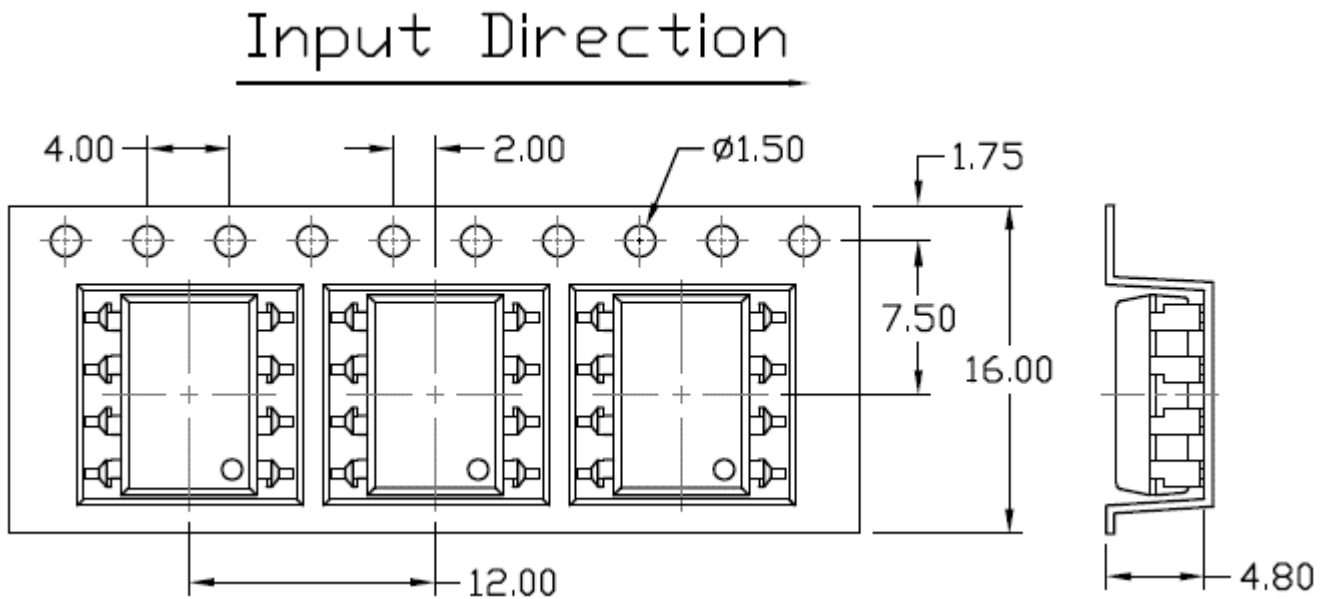


Carrier Tape Specifications *Dimensions in mm unless otherwise stated*

Option S(T1) & SL(T1)



Option S(T2) & SL(T2)





Solderability spec (Follow the JEDEC standard JESD22-B102)

Reflow Soldering: Immersed surface, other than the end of pin as cut-surface, must be covered by solder.

Solder-Bath: More than 95% of the electrode must be covered with solder.

Wave soldering (Follow the JEDEC standard JESD22-A111)

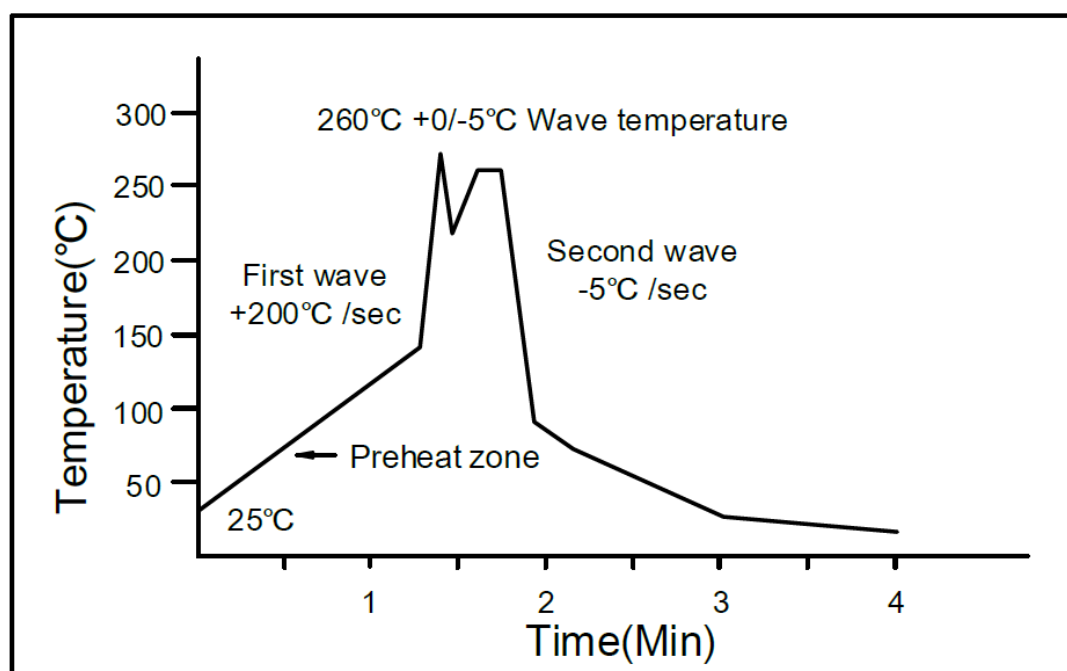
One time soldering is recommended within the condition of temperature.

Temperature: $260 \pm 0/-5^{\circ}\text{C}$.

Time: 10 sec.

Preheat temperature: 25 to 140°C .

Preheat time: 30 to 80 sec.



Iron soldering (Follow the standard MIL-STD 202G, Method 210F)

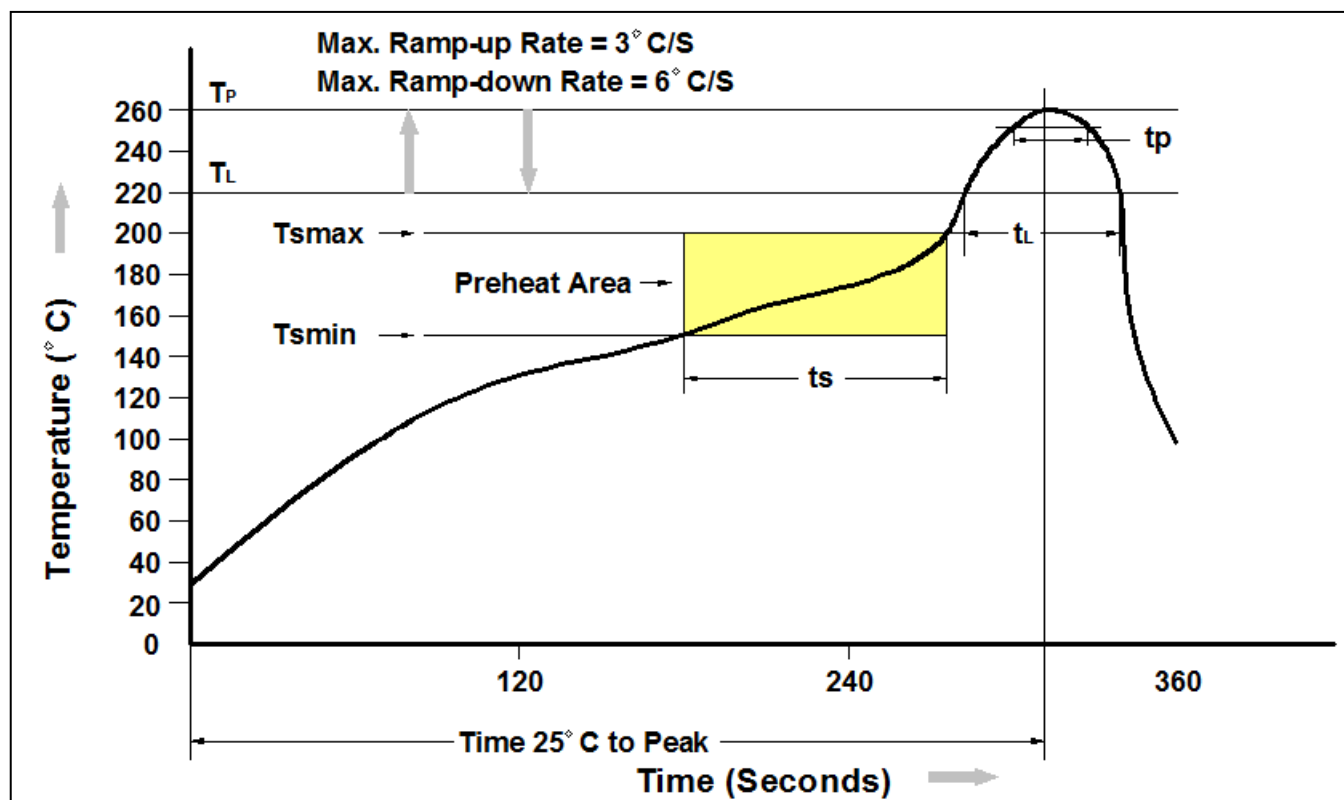
Allow single lead soldering in every single process.

One time soldering is recommended. Temperature: $350 \pm 10^{\circ}\text{C}$

Time: 5 sec max.



Reflow Profile (Follow the JEDEC standard J-STD-020)



Profile Feature	Pb-Free Assembly Profile
Temperature Min. (Tsmmin)	150°C
Temperature Max. (Tsmax)	200°C
Time (ts) from (Tsmmin to Tsmax)	60-120 seconds
Ramp-up Rate (tL to tp)	3°C/second max.
Liquidous Temperature (TL)	217°C
Time (tL) Maintained Above (TL)	60 – 150 seconds
Peak Body Package Temperature	260°C +0°C / -5°C
Time (tp) within 5°C of 260°C	30 seconds
Ramp-down Rate (TP to TL)	6°C/second max
Time 25°C to Peak Temperature	8 minutes max.



High CMR, 1Mbit/s High Speed Optocoupler

DISCLAIMER

CT MICRO RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN. CT MICRO DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

DISCOLORATION MIGHT OCCUR ON THE PACKAGE SURFACE AFTER SOLDERING, REFLOW OR LONG TERM USE. THIS DOES NOT IMPACT THE PRODUCT PERFORMANCE NOR THE PRODUCT RELIABILITY.

CT MICRO ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT EXPRESS WRITTEN APPROVAL OF CT MICRO INTERNATIONAL CORPORATION.

- 1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instruction for use provided in the labelling, can be reasonably expected to result in significant injury to the user.*
- 2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.*